Enhanced emission from Si-based light-emitting diodes using surface plasmons

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Excitation of surface plasmons on metallic nanoparticles has potential for increasing the absorption and emission from thin Si devices. We report an eight-fold enhancement in electroluminescence from silicon-on-insulator light-emitting diodes at 900 nm via excitation of surface plasmon resonance in silver nanoparticles, along with a redshift in the electroluminescence by 70 nm by overcoating the nanoparticles with ZnS. The enhancement is due to coupling between the electromagnetic excitations of the silver nanoparticles and the waveguide modes. © 2006 American Institute of Physics. [DOI: 10.1063/1.2195695]

The need to integrate optical functionality into computer chips, e.g., for faster data communication is attracting a lot of research related to the development of integrated light-emitting diodes (LEDs) or lasers. Si is a strong contender in spite of it being an indirect band-gap material as it is cheaper and easier to integrate into Si microchips. The luminescence quantum efficiency for band edge light emission from Si can be improved by surface passivation and light trapping, as was demonstrated in record efficiency wafer-based bulk Si LEDs. However, for thin films, light trapping using the conventional technique of surface texture with features which are typically around 10 microns in size, would be at the cost of the already thin semiconductor layer and would cause increased recombination losses. In this work, we propose the use of nanoscale metal particles as an effective method for increasing light emission as well as light absorption in thin-film Si devices.

Surface plasmons are the collective oscillation of free electrons in a metal. They occur at the interfaces between metals and dielectrics and decay exponentially with distance from the interface. Because of the large free electron density of metals, they show strong resonances at optical frequencies. Deposition of gold nanoparticles showed increased absorption from a pn junction fabricated on a Si wafer and an eighteen-fold increase in the photocurrent at 800 nm from silicon-on-insulator (SOI) photodetectors coated with silver nanoparticles was reported, both effects being ascribed to the effect of surface plasmons. The plasmon effect can be used not only to enhance photocurrent from devices, but also to increase the efficiency with which internally generated photons are extracted from the waveguide in light-emitting diodes. The surface plasmon resonance frequency for nanospheres is given by

\[ \omega_{sp} = \frac{\omega_p}{\sqrt{1 + 2\epsilon_m}}, \]

where \( \omega_p \) is the plasma frequency and \( \epsilon_m \) is the permittivity of the medium which can be taken as the average of the substrate and the surrounding medium and written as \( \epsilon_m = (\epsilon_{\text{sub}} + \epsilon_{\text{ext}})/2 \). From Eq. (1), it can be clearly seen that by varying \( \epsilon_m \) the surface plasmon frequency can be tuned, and that increasing the permittivity of the medium leads to a redshift of the plasmon resonance. Shifting the plasmon resonance has been demonstrated by overcoating or sandwiching the metal particles in a high refractive index medium. Equation (1) is valid for thick substrates but has been used here in a general context to help understand the effect of dielectric overcoating.

The basic device structure used here is shown schematically in Fig. 1. It consists of a lateral pn junction fabricated on SOI substrates. We deposit metal nanoparticles on the SOI structure and use the coupling of the broad surface plasmon resonance and the waveguide modes to scatter internally emitted light out of the silicon. Overcoating the islands with ZnS is then used to redshift the surface plasmon resonance. The enhancement in the emission and absorption properties are studied using electroluminescence (EL) and spectral response (SR) measurements, emphasizing the potential of surface plasmons for both enhanced emission and absorption, respectively.

The layers of the device structure are: A 35 nm thick passivating top oxide layer which acts as a spacer layer as well, 95 nm Si active layer and 400 nm thick buried oxide layer. Because the total recombination in SOI devices is dominated by the surface recombination the passivation of the top silicon layer is imperative but for maximum coupling between the silver particles and the Si waveguide the thickness of the top oxide layer is kept at the minimum thickness required for good passivation. The p and n metal fingers are interdigitated on the front surface for maximum carrier injection. A thin layer of 14 nm silver is deposited by vacuum evaporation at 3 × 10−5 torr at the rate of approximately

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FIG. 1. (Color online) Schematic of SOI LED used in the experiments.
2 Å/sec. The samples are then annealed in nitrogen at 200°C for 55 min. The metal particles coalesce together to form metal islands. The shape and the size of the islands depend on the substrate, thickness of the evaporated layer and also on the annealing temperature and time. Analysis of SEM and AFM images using image processing software show the average particle size to be around 120–140 nm in diameter and around 45–60 nm in height. A thin layer of 30 nm ZnS was then evaporated on the metal islands at 1 × 10⁻⁶ torr. The thickness was so chosen that the ZnS layer acts as a dielectric layer but does not introduce additional waveguide modes.

The “bare” island resonance for islands deposited on a microscope glass slide was measured separately using transmittance measurements for the cases with islands only and for the ZnS overcoated islands. Figure 3 shows a very evident redshift in the resonance at the dip in the transmittance measurement.

EL and spectral response of each device were measured before and after deposition of the metal islands and after deposition of the additional ZnS layer, respectively. A reference sample was used in each case to check for the repeatability of the measurements which were typically carried out several days apart.

Typical results of the EL measurements are shown in Fig. 4(a). The corresponding enhancement for the case with islands only and for the case with overcoated islands is shown in Fig. 4(b), where the enhancement is the ratio of the EL or photocurrent signal over the signal before island deposition. Our results show a factor of approximately 8 times enhancement in emission from the SOI LEDs at a wavelength of 900 nm. We estimate the variations in the experimental setup to be <20% and hence the observed enhancement can clearly be assigned to the presence of the metal islands rather than to variations in the experimental conditions.

A further redshift and an overall enhancement in EL is observed after overcoating the metal nanoparticles with ZnS, which is a dielectric layer of refractive index 2.2. The total enhancement integrated across the emission spectrum is a factor of 2.8 for uncoated islands, and 3.2 for overcoated islands.

We deposited two-thirds of a LED with silver islands and measured the EL from the LED. The emission was captured by a charge coupled device (CCD) camera and is shown in Fig. 5. There is clear evidence for the increase in intensity from the area with the nanoparticles. The average emission intensity is about five times higher from the area with metal islands. Taking into account the sensitivity of the CCD camera, which is more sensitive at a short wavelength where the enhancement is most pronounced, this figure is consistent with the data from Fig. 4. The enhancement for the photocurrent as calculated from the spectral response of a device is shown in Fig. 6.

According to a generalized form of Kirchoff’s law, which is valid for luminescent emission, enhanced emittance...
The enhancement in emission and absorption occurs because the metal particles can excite surface plasmons and when they are in the near field of the waveguide they couple strongly with the waveguide modes.\(^5\) For emission, only a small fraction of the waveguided light is coupled out of the waveguide in each interaction with the metal nanoparticles, but because the band edge light is very weakly absorbed, the emission is significantly enhanced after multiple scattering events. The position of the peaks occur at the waveguide cut-off frequencies,\(^11\) but can be shifted somewhat by altering the bare island resonance of the nanoparticles. The scattering by the metal nanoparticles, which is proportional to the extinction, tends to decrease with wavelength in the absence of the waveguide structure as shown in Fig. 3. If we consider the scattering when the waveguide is present to be a product of the bare island resonance and a factor describing the interaction of the nanoparticles with the waveguide modes, then we can see that redshifting the bare island resonance peak (by overcoating) will also redshift the scattering peaks in the combined system. The redshift is larger at long wavelengths, as is evident from the photocurrent enhancement peaks in Fig. 6. This is because the change in the bare island resonance with an overcoating is larger at long wavelengths.

A major advantage of the surface plasmon approach is that, unlike texturing of the silicon, the application of the metal nanoparticles—which are separated from the silicon by a thin spacer layer—will not degrade the electrical characteristics of the device. The metal islands are deposited by a simple process of evaporation and low-temperature annealing, and can be formed as the last stage of the device processing so there are no processing incompatibilities.

We demonstrate an eight-fold increase in the EL signal at 900 nm, and an overall factor of 3 enhancement from silicon-based devices using a very simple deposition process. We also report the use of overcoating the surface plasmon resonance to redshift and increase the enhancement. This is a very promising result with the potential to not only increase light emission from thin films of varying substrates but to increase the photocurrent from solar cells.

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